

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

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Testing Laboratory Name	Shenzhen CTA Testing Technology Co., Ltd.
Address:	Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community Fuhai Street, Baoʻan District, Shenzhen, China
Applicant's name	Shenzhen kehuitong Technology Co., Ltd
Address	F3.830306G, 3rd Floor, Tianan Code City Tianjing Building, No.6 Tianan Road, Shatou Street, Futian District, Shenzhen, China
Test specification	-ING
	FCC CFR Title 47 Part 2, Part 24E
Standard	
C.	KDB 971168 D01
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Equipment under Test

Model /Type

Listed Models

Applicant

Address

:

•

:

A1

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TEST REPORT



F3.830306G, 3rd Floor, Tianan Code City Tianjing Building, No.6 Tianan Road, Shatou Street, Futian District, Shenzhen, China

Manufacturer :

CTATESTING Address

F3.830306G, 3rd Floor, Tianan Code City Tianjing Building, No.6 Tianan Road, Shatou Street, Futian District, Shenzhen, China

Pass *

Shenzhen kehuitong Technology Co., Ltd

Test result

* In the configuration tested, the EUT complied with the standards specified page 4.

The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test result without the written permission of the test laboratory. CTATES



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SUMMARY 1

1.1 TEST STANDARDS

The tests were performed according to following standards:

FCC Part 2: FREQUENCY ALLOCA-TIONS AND RADIO TREATY MAT-TERS; GENERAL RULES AND REG-ULATIONS

FCC Part 24 Subpart E: PUBLIC MOBILE SERVICES

ANSI/TIA-603-E-2016: Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

ANSI C63.26-2015: IEEE/ANSI Standard for Compliance Testing of Transmitters Used in Licensed COM CTATES Radio Services

FCCKDB971168D01 Power Meas License Digital Systems

1.2 **Test Description**

Test Item	Section in CFR 47	Result
RF Output Power	Part 2.1046 Part 24.232 (c)	Pass
Peak-to-Average Ratio	Part 24.232 (d)	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 24.238	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 24.238 (a)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 24.238 (a)	Pass
Out of band emission, Band Edge	Part 22.917 (a) Part 24.238 (a)	Pass
Frequency stability	Part 2.1055 Part 24.235	Pass
1.3 Address of the test laboratory	George	G CT

1.3 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.4:2014 and CISPR 16-1-4:2010 SVSWR requirement for radiated emission above 1GHz.

1.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Industry Canada Registration Number. Is: 27890 CAB identifier: CN0127

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.



1.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01"Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 1"and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 2" and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10 dB	(1)
Radiated Emission	1~18GHz	4.32 dB	(1)
Radiated Emission	18-40GHz	5.54 dB	(1)
Conducted Disturbance	0.15~30MHz	3.12 dB	(1)
Conducted Power	9KHz~18GHz	0.61 dB	(1)
Spurious RF Conducted Emission	9KHz~40GHz	1.22 dB	(1)
Band Edge Compliance of RF Emission	9KHz~40GHz	1.22 dB	(1)
Occupied Bandwidth	9KHz~40GHz	-	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.



2 GENERAL INFORMATION

2.1 Environmental conditions

Date of receipt of test sample	•	Sep. 25, 2024
TETING		
Testing commenced on	:	Sep. 25, 2024
GIL		GTINC
Testing concluded on	:	Oct. 28, 2024
	Contro	C C V

During the measurement the environmental conditions were within the listed ranges:

build and medsarement the environmental ber	iditions were within the isted ranges.		
Normal Temperature:	25°C	TES	
Relative Humidity:	55 %	AL	
Air Pressure:	101 kPa	(CTA)	
-INO		A CONTRACTOR OF THE OWNER OWNER OF THE OWNER OWNER OF THE OWNER OWN	

2.2 General Description of EUT

Product Name:	mobile phone
Model/Type reference:	A1 TING
Power supply:	DC 3.87V From battery and DC 5.0V From external circuit
Adapter information (Auxiliary test supplied by test Lab):	Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5V 2.0A
Hardware version:	V722TE_MB_V1.0_20240323
Software version:	v722te_v1.0_2460 1080 huaxing kf10d13 q4 w12458 f1234578121720252628AB66T3438394041_4GB_128GB_user debug_20240924_09_04
Testing sample ID :	CTA241008003-1# (Engineer sample) CTA241008003-2# (Normal sample)
LTE	
Operation Band:	E-UTRA Band 2
Support Bandwidth:	Band 2: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz
TX/RXFrequency Range:	E-UTRA Band 2(1850 MHz -1910MHz)
Modulation Type:	QPSK, 16QAM
Release Version:	Release 9
Category:	Cat 4
Antenna Type:	PIFA antenna
Antenna Gain:	0.8 dBi

Note: For more details, refer to the user's manual of the EUT.

2.3 Description of Test Modes and Test Frequency

The EUT has been tested under typical operating condition. The CMW500 used to control the EUT staying in continuous transmitting and receiving mode for testing. Regards to the frequency band operation: the lowest, middle and highest frequency of channel were selected to perform the test, then shown on this report.



2.4 Equipments Used during the Test

Test Equipment	Manufacturer	Model No.	Equipment	Calibration	Calibration
			No.	Date	Due Date
LISN	R&S	ENV216	CTA-308	2024/08/03	2025/08/02
LISN	R&S	ENV216	CTA-314	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESPI	CTA-307	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESCI	CTA-306	2024/08/03	2025/08/02
Spectrum Analyzer	Agilent	N9020A	CTA-301	2024/08/03	2025/08/02
Spectrum Analyzer	R&S	FSU	CTA-337	2024/08/03	2025/08/02
Vector Signal generator	Agilent	N5182A	CTA-305	2024/08/03	2025/08/02
Analog Signal Generator	R&S	SML03	CTA-304	2024/08/03	2025/08/02
WIDEBAND RADIO COMMUNICATIO N TESTER	CMW500	R&S	CTA-302	2024/08/03	2025/08/02
Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2024/08/03	2025/08/0
Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2026/10/1
Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2026/10/1
Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2026/10/1
Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2023/10/17	2026/10/1
Amplifier	Schwarzbeck	BBV 9745	CTA-312	2024/08/03	2025/08/0
Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2024/08/03	2025/08/0
Directional coupler	NARDA	4226-10	CTA-303	2024/08/03	2025/08/0
High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2024/08/03	2025/08/0
High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2024/08/03	2025/08/02
Automated filter bank	Tonscend	JS0806-F	CTA-404	2024/08/03	2025/08/0
Power Sensor	M ^G Agilent	U2021XA	CTA-405	2024/08/03	2025/08/0
Amplifier	Schwarzbeck	BBV9719	CTA-406	2024/08/03	2025/08/0
6.	(Con Con	TATES	General CTAT	ESTING	

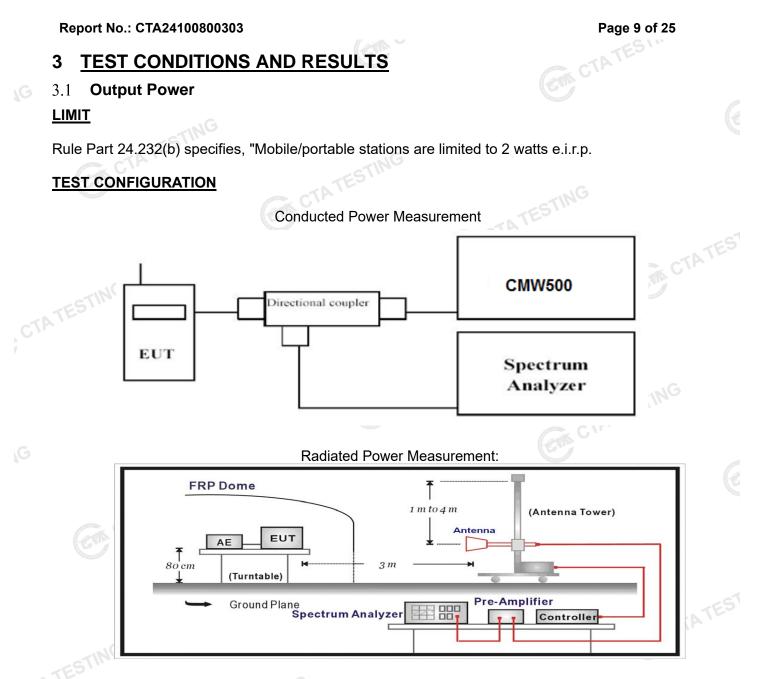
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Test Equipment	Manufacturer	Model No.	Version	Calibration	Calibration	
EMI Test Software	Tonscend	TS®JS32-RE	number 5.0.0.2	Date N/A	Due Date N/A	
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A	
			CTA CTA		CTA CTA	(ES
2.5 Related Subn	nittal(s) / Grant ((s)				
This submittal(s) (te	st report) is filing to	o comply with of the	FCC Part 24	Rules.		

2.5 Related Submittal(s) / Grant (s)

2.6 Modifications

CTA TESTING No modifications were implemented to meet testing criteria.



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Conducted Power Measurement:

- a) Place the EUT on a bench and set it in transmitting mode.
- b) Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- c) EUT Communicate with CMW500 then selects a channel for testing.
- d) Add a correction factor to the display of spectrum, and then test.

Radiated Power Measurement:

- a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b) The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c) The output of the test antenna shall be connected to the measuring receiver.
- d) The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e) The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.

- The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum f) signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g) maximum signal level is detected by the measuring receiver.
- The maximum signal level detected by the measuring receiver shall be noted. h)
- i) The transmitter shall be replaced by a substitution antenna.
- The substitution antenna shall be orientated for vertical polarization and the length of the j) substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k) The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to I) increase the sensitivity of the measuring receiver.
- m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received that the maximum signal is received.
- The input signal to the substitution antenna shall be adjusted to the level that produces a level n) detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- The measurement shall be repeated with the test antenna and the substitution antenna 0) orientated for horizontal polarization.
- The measure of the effective radiated power is the larger of the two levels recorded at the input p) to the substitution antenna, corrected for gain of the substitution antenna if necessary. CTA CTA
- Test site anechoic chamber refer to ANSI C63.4. q)

TEST RESULTS

Conducted Measurement:

				0		
BW	Modulation	RB Size	RB Offset	Cha	innel/Frequency(MH	lz)
(MHz)	Modulation	IND OIZE		18700	18900	19100
				1860	1880	1900
20	QPSK	1	0	23.22	23.91	23.67
20	QPSK	1	49	23.32	23.65	23.87
20	QPSK	1	99	23.25	23.74	23.32
20	QPSK	50	0	22.39	22.30	22.44
20	QPSK	50	24	22.58	22.15	22.22
20	QPSK	50	50	22.59	22.45	22.35
20	QPSK	100	0	22.31	22.36	22.59
20	16QAM	1	0	22.58	22.41	22.65
20	16QAM	1	49	22.25	22.53	22.45
20	16QAM	1	99	22.50	22.41	22.25
20	16QAM	50	0	21.49	21.53	21.59
20	16QAM	50	24	21.37	21.44	21.64
20	16QAM	50	50	21.37	21.25	21.43
20	16QAM	100	0	21.55	21.73	21.41
BW (MHz)	Modulation	RB Size	RB Offset	Cha 18675	Innel/Frequency(MH	lz) 19125
()			-	1857.5	1880	1902.5
15	QPSK	1	0	23.55	23.42	23.35
15	QPSK	1	37	23.58	23.96	23.72
15	QPSK	1	74	23.16	23.40	23.22
15	QPSK	36	0	22.37	22.37	22.60
15	QPSK	36	20	22.52	22.17	22.25
15	QPSK	36	39	22.45	22.56	22.18
15	QPSK	75	0	22.31	22.38	22.53
15	16QAM	1	0	22.60	22.42	22.33
15	16QAM	1	37	22.00	22.66	22.58
15	16QAM	1	74	22.13	22.00	22.35
15	16QAM 16QAM	36	0	21.75	21.47	22.55
15	16QAM 16QAM	36	20	21.75	21.47	21.31
15	16QAM 16QAM	36	39	21.59	21.40	21.60
	16QAM 16QAM	75	0	21.39	21.72	21.00
15	IUQAIVI	15	0	21.41	21.10	21.20
15 TESTING		TESTING				

BW (MHz)	Modulation	RB Size	RB Offset	18650	18900	19150
· · · ·			-	1855	1880	1905
10	QPSK	1	0	23.48	23.35	23.27
10	QPSK	1	25	23.85	23.85	23.13
10	QPSK	1	49	23.97	23.71	23.75
10	QPSK	25	0	22.41	22.56	22.36
10	QPSK	25	12	22.24	22.45	22.59
10	QPSK	25	25	22.67	22.26	22.20
10	QPSK	50	0	22.47	22.63	22.54
10	16QAM	1	0	22.54	22.47	22.14
10	16QAM	1	25	22.51	22.46	22.18
10	16QAM	1	49	22.53	22.67	22.48
10	16QAM	25	0	21.30	21.64	21.65
10	16QAM	25	12	21.55	21.47	21.58
10	16QAM	25	25	21.46	21.57	21.64
10	16QAM	50	0	21.27	21.56	21.84
BW (MHz)	Modulation	RB Size	RB Offset	Ch 18625 1852.5	annel/Frequency(N 18900 1880	MHz) 19175 1907.5
5	QPSK	1	0	23.91	23.26	23.47
5	QPSK	1	12	23.79	23.82	23.64
5	QPSK	1	24	23.57	23.74	23.47
5	QPSK	12	0	22.25	22.13	22.56
5	QPSK	12	7	22.57	22.41	22.14
5	QPSK	12	13	22.47	22.59	22.39
5	QPSK	25	0	22.14	22.66	22.12
5	16QAM	1	0	22.37	22.30	22.43
5	16QAM	1	12	22.46	22.44	22.42
5	16QAM	1	24	22.27	22.52	22.69
5	16QAM	12	0	21.53	21.52	21.51
5	16QAM	12	7	21.53	21.29	21.52
5	16QAM	12	13	21.27	21.66	21.25
5	16QAM	25	0	21.59	21.51	21.38
				GA C		Con CTI

BW (MHz)	Modulation	RB Size	RB Offset	40045	40000	40405
(101112)			-	18615	18900	19185
	0001/	4	0	1851.5	1880	1908.5
3	QPSK	1	0	23.82	23.65	23.33
3	QPSK	1	8	23.41	23.44	23.83
3	QPSK	1	14	23.73	23.62	23.31
3	QPSK	8	0	22.25	22.47	22.53
3	QPSK	8	4	22.37	22.58	22.10
3	QPSK	8	7	22.46	22.05	22.24
3	QPSK	15	0	22.23	22.27	22.29
3	16QAM	1	0	22.56	22.30	22.26
3	16QAM	1	8	22.25	22.45	22.27
3	16QAM	1	14	22.33	22.28	22.23
3	16QAM	8	0	21.43	21.56	21.44
3	16QAM	8	4	21.57	21.49	21.70
3	16QAM	8	7	21.54	21.27	21.56
3	16QAM	15	0	21.38	21.34	21.62
BW (MHz)	Modulation	RB Size	RB Offset	Ch 18607	annel/Frequency(N	IHz) 19193
× /			-	1850.7	1880	1909.3
1.4	QPSK	1	0	23.72	23.83	23.77
1.4	QPSK	1	3	23.72	23.64	23.05
1.4	QPSK	1	5	23.96	23.68	23.75
1.4	QPSK	3	0	22.52	22.09	22.31
1.4	QPSK	3	1	22.14	22.15	22.35
1.4	QPSK	3	3	22.57	22.45	22.30
1.4	QPSK	6	0	22.37	22.06	22.22
1.4	16QAM	1	0	22.36	22.37	22.31
1.4	16QAM	1	3	22.48	22.72	22.41
1.4	16QAM	1	5	22.27	22.33	22.51
1.4	16QAM	3	0	21.62	21.49	21.58
1.4	16QAM	3	1	21.56	21.19	21.33
1.4	16QAM	3	3	21.26	21.41	21.57
1.4	16QAM	6	0	21.30	21.26	21.55
1.7	TUQAIN	0	0	21.00	21.20	
				Car C		GA CT

Radiated Measurement: Remark:

- - 1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 2; recorded worst case for each Channel Bandwidth of LTE FDD Band 2.
 - 2. $EIRP=P_{Mea}(dBm)-P_{cl}(dB)+P_{Ag}(dB)+G_{a}(dBi)$

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	
1850.7	-16.30	3.41	10.23	33.6	24.12	33.01	-8.89	V	
1880.0	-15.32	3.49	10.23	33.6	25.02	33.01	-7.99	V	TES
1909.3	-16.34	3.55	10.25	33.6	23.96	33.01	-9.05	V CTP	

LTE FDD Band 2 Channel Bandwidth 1.4MHz QPSK

LTE FDD Band	2 Channel Bandwidth	3MHz QPSK

CTP	Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
	1851.5	-18.58	3.41	10.23	33.6	21.84	33.01	-11.17	V
	1880.0	-17.31	3.49	10.23	33.6	23.03	33.01	-9.98	VG
	1908.5	-18.81	3.55	10.25	33.6	21.49	33.01	-11.52	SV
	LTE FDD Ba	nd 2 Char	nel Randı	width 5MHz	OPSK			CTA	TES
			nici Danuv						
				G					

LTE FDD Band 2_Channel Bandwidth 5MHz_QPSK

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} G (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1852.5	-18.30	3.41	10.23	33.6	22.12	33.01	-10.89	V
1880.0	-19.55	3.49	10.23	33.6	20.79	33.01	-12.22	V
1907.5	-19.29	3.55	10.25	33.6	21.01	33.01	-12.00	V
LTE FDD Bai	nd 2_Char	nnel Band	width 10MH	z_QPSK		TE	STING	
			C C			272		

LTE FDD Band 2 Channel Bandwidth 10MHz QPSK

	Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	TEST
	1855.0	-20.48	3.41	10.23	33.6	19.94	33.01	-13.07	V	
	1880.0	-20.28	3.49	10.23	33.6	20.06	33.01	-12.95	V	
TA	1905.0	-20.02	3.55	10.25	33.6	20.28	33.01	-12.73	V	
CV.			10	TIN						-

LTE FDD Band 2_Channel Bandwidth 15MHz_QPSK

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1857.5	-19.26	3.41	10.23	33.6	21.16	33.01	-11.85	V
1880.0	-20.36	3.49	10.23	33.6	19.98	33.01	-13.03	V
1902.5	-19.24	3.55	10.25	33.6	21.06	33.01	-11.95	V

LTE FDD Band 2_Channel Bandwidth 20MHz_QPSK

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	
1860.0	-20.58	3.41	10.23	33.6	19.84	33.01	-13.17	V	
1880.0	-20.56	3.49	10.23	33.6	19.78	33.01	-13.23	V	
1900.0	-19.03	3.55	10.25	33.6	21.27	33.01	-11.74	V	12-
STING					G	7		COM CTA	TEST

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LTE FDD Band 2_Channel Bandwidth 1.4MHz_16QAM

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G₃ Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1850.7	-17.30	[©] 3.41	10.23	33.6	23.12	33.01	-9.89	V
1880.0	-17.25	3.49	10.23	33.6	23.09	33.01	-9.92	V
1909.3	-16.84	3.55	10.25	33.6	23.46	33.01	-9.55	V
	•		4	ES		•	-	•

LTE FDD Band 2 Channel Bandwidth 3MHz 16QAM

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G₂ Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	TEST
1851.5	-19.37	3.41	10.23	33.6	21.05	33.01	-11.96	V CVP	
1880.0	-18.46	3.49	10.23	33.6	21.88	33.01	-11.13	V	
1908.5	-18.44	3.55	10.25	33.6	21.86	33.01	-11.15	V	

LTE FDD Band 2_Channel Bandwidth 5MHz_16QAM

Frequency (MHz)	P _{Mea} (dBm)	(dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1852.5	-21.98	3.41	10.23	33.6	18.44	33.01	-14.57	-csV
1880.0	-21.63	3.49	10.23	33.6	18.71	33.01	-14.30	V
1907.5	-21.02	3.55	10.25	33.6	19.28	33.01	-13.73	V

LTE FDD Band 2_Channel Bandwidth 10MHz_16QAM

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1855.0	-19.27	3.41	10.23	33.6	21.15	33.01	-11.86	V
1880.0	-20.18	3.49	10.23	33.6	20.16	33.01	-12.85	V
1905.0	-21.03	3.55	10.25	33.6	19.27	33.01	-13.74	V
LTE FDD Bai	nd 2_Chan	nel Bandi	width 15MH	z_16QAM	E	CIA		
			G		25.000			

LTE FDD Band 2_Channel Bandwidth 15MHz_16QAM

	LTE FDD Bai	nd 2_Char	nnel Band	width 15MH	z_16QAM	en	CIT		
	Frequency (MHz)	Р _{меа} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1A	1857.5	-21.76	3.41	10.23	33.6	18.66	33.01	-14.35	V
	1880.0	-20.78	3.49	10.23	33.6	19.56	33.01	-13.45	V
	1902.5	-20.30	3.55	10.25	33.6	20.00	33.01	-13.01	V

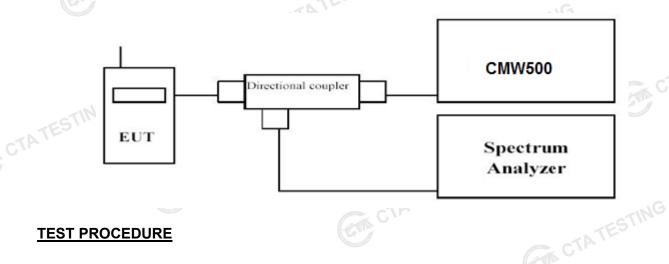
1902.5	-20.00	0.00	10.25	55.0	20.00	00.01	-10.01	v
LTE FDD Bai	nd 2_Char	nel Band	vidth 20MH	z_16QAM	ATEST			
Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	G _a Antenna Gain(dB)	P _{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1860.0	-20.67	3.41	10.23	33.6	19.75	33.01	-13.26	V
1880.0	-21.31	3.49	10.23	33.6	19.03	33.01	-13.98	V
1900.0	-21.79	^o 3.55	10.25	33.6	18.51	33.01	-14.50	V
CTATES CTATESTING								

3.2 Peak-to-Average Ratio (PAR)

LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

- 1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
 - 2. Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
 - 3. Set the number of counts to a value that stabilizes the measured CCDF curve;
 - 4. Set the measurement interval as follows:
 - 1). for continuous transmissions, set to 1 ms,

2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst stabilize and set the measurement interval to a time that is less than or equal to the burst duration.

-Passed-----

5. Record the maximum PAPR level associated with a probability of 0.1%.

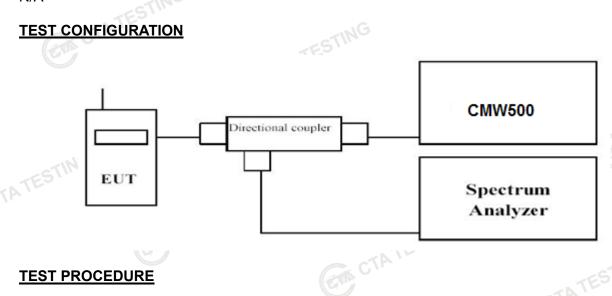
TEST RESULTS

Please refer to the appendix test data.

3.3 Occupied Bandwidth and Emission Bandwidth

LIMIT

N/A



TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.

Set RBW was set to about 1% of emission BW, VBW≥3 times RBW.

-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace. -----Passed-----

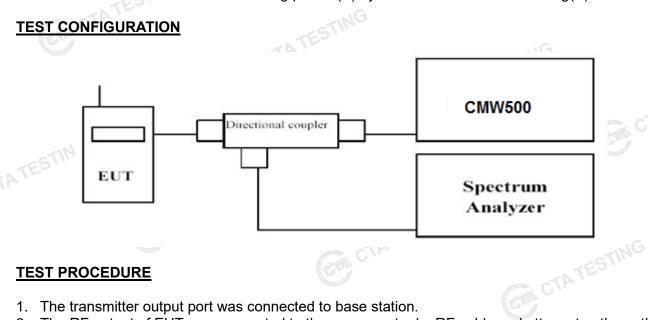
TEST RESULTS

JSE I Please refer to the appendix test data.

Band Edge compliance 3.4

<u>LIM</u>IT

Per FCC §24.238 the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10log(P) dB.



TEST PROCEDURE

- 1. The transmitter output port was connected to base station.
- 2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
- 3. Set EUT at maximum power through base station.
- 4. Select lowest and highest channels for each band and different modulation.
- 5. Measure Band edge using RMS (Average) detector by spectrum CTA TESTING

TEST RESULTS

-Passed---

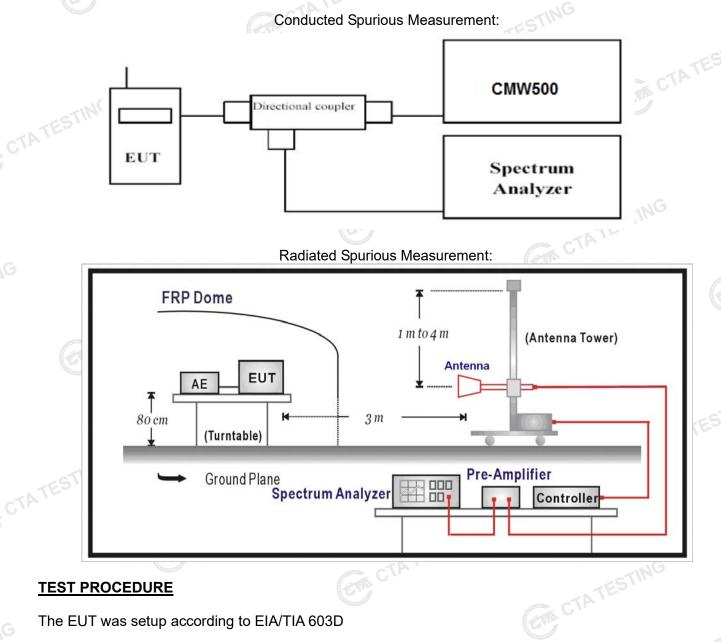
ctates Please refer to the appendix test data. GA CTATESTING

Spurious Emission 3.5

LIMIT

Per FCC §24.238, the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10log(P) dB.

TEST CONFIGURATION



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Conducted Spurious Measurement:

- a. Place the EUT on a bench and set it in transmitting mode.
- b. Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a **Directional Couple.**
- c. EUT Communicate with CMW500 then selects a channel for testing.
- d. Add a correction factor to the display of spectrum, and then test.
- e. The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show CTA TEST the out of band Emission if any up to10th harmonic.

Radiated Spurious Measurement:



- a. The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c. The output of the test antenna shall be connected to the measuring receiver.
- d. The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e. The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- f. The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g. maximum signal level is detected by the measuring receiver.
- h. The maximum signal level detected by the measuring receiver shall be noted.
- The transmitter shall be replaced by a substitution antenna. ì.
- The substitution antenna shall be orientated for vertical polarization and the length of the j. substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k. The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to Ι. increase the sensitivity of the measuring receiver.
- m. The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n. The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o. The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p. The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- CTATEST q. The resolution bandwidth of the spectrum analyzer was set at 100 kHz for Part 22 and 1MHz for Part 24. The frequency range was checked up to 10th harmonic.
- r. Test site anechoic chamber refer to ANSI C63.

TEST RESULTS



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Conducted Measurement:

-----Passed------

Please refer to the appendix test data.



Radiated Measurement:

Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 2; TES

LTE FDD Band 2	Channel Bandv	vidth 20MHz_	QPSK_	Low Chani	nel

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	Distance (m)	G₂ Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
3715.0	-44.94	4.25	3.00	12.34	-36.85	-13.00	-23.85	Н
5572.5	-55.10	4.97	3.00	13.52	-46.55	-13.00	-33.55	Н
3715.0	-42.40	4.25	3.00	12.34	-34.31	-13.00	-21.31	V CTP
5572.5	-49.85	4.97	3.00	13.52	-41.30	-13.00	-28.30	V
TINC								Contraction of the

LTE FDD Band 2 Channel Bandwidth 20MHz QPSK Middle Channel

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	Distance (m)	G _a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
3720.0	-45.25	4.38	3.00	12.34	-37.29	-13.00	-24.29	HG
5580.0	-51.14	5.01	3.00	13.58	-42.57	-13.00	-29.57	STH
3720.0	-41.96	4.38	3.00	12.34	-34.00	-13.00	-21.00	V
5580.0	-52.31	5.01	3.00	13.58	-43.74	-13.00	-30.74	V

LTE FDD Band 2 Channel Bandwidth 20MHz QPSK High Channel

Frequency (MHz)	P _{Mea} (dBm)	G P _{cl} (dB)	Distance (m)	G _a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
3800.0	-45.71	4.49	3.00	12.45	-37.75	-13.00	-24.75	Н		
5700.0	-51.56	5.26	3.00	13.66	-43.16	-13.00	-30.16	Н		
3800.0	-41.88	4.49	3.00	12.45	-33.92	-13.00	-20.92	V		
5700.0	-46.31	5.26	3.00	13.66	-37.91	-13.00	-24.91	V	10	
Notes:										
1.All channel bandwidth were tested, the report recorded the worst data.										
2. EIRP=PMea(dBm)-Pcl(dB)+PAg(dB)+Ga(dBi)										
3. ERP = EIRF	3. ERP = EIRP – 2.15dBi as EIRP by subtracting the gain of the dipole.									

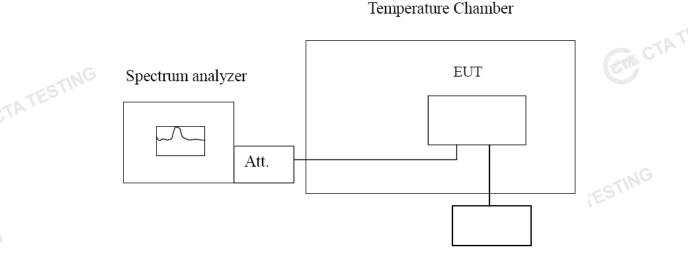
4. Margin = EIRP - Limit

5. We measured all modes and only recorded the worst case.

LIMIT

According to §24.235, §2.1055 requirement, the frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation and should not exceed CTATESTING 2.5ppm.

TEST CONFIGURATION



Variable Power Supply

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TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Frequency Stability under Temperature Variations:

CTATESTING In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a "call mode". This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

- Measure the carrier frequency at room temperature. 1.
- 2. Subject the EUT to overnight soak at -30°C.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 3. on middle channel for LTE band 2, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- Repeat the above measurements at 10℃ increments from -30℃ to +50℃. Allow at least 1.5 4. hours at each temperature, unpowered, before making measurements.
- 5. Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage from minimum voltage to maximum voltage, in 0.1Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any selfheating to stabilize, before continuing.
- Subject the EUT to overnight soak at +50°C. 6.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 7. on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- Repeat the above measurements at 10 °C increments from +50 °C to -30 °C. Allow at least 1.5 8. hours at each temperature, unpowered, before making measurements

At all temperature levels hold the temperature to $+/-0.5^{\circ}$ C during the measurement procedure. 9. Frequency Stability under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.

TEST RESULTS



\G

-----Passed------

Please refer to the appendix test data.



